

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10576653	CHENG ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	CECILIA M JAISLE	1624

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
514	256, 269, 272, 274, 275	11/3/2009	C. Jaisle
544	297, 298, 309, 322, 323, 334, 335	11/3/2009	C. Jaisle

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
STIC searched STN & Inventor Names	5/3/2008	C. Jaisle

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
514	256, 269, 272, 274, 275	11/3/2009	CJ
544	297, 298, 309, 322, 323, 334, 335	11/3/2009	CJ

/Cecilia M Jaisle/  
Examiner.Art Unit 1624